Dual MOSFET Bootstrapped Driver with Break-Before-Make

FEATURES

- 4.5- to 5.5-V Operation
- Undervoltage Lockout
- 250-kHz to 1-MHz Switching Frequency
- Shutdown Quiescent Current <5 μA
- One Input PWM Signal Generates Both Drive
- Bootstrapped High-Side Drive
- Operates from 4.5- to 30-V Supply
- TTL/CMOS Compatible Input Levels
- 1-A Peak Drive Current

APPLICATIONS

- Multiphase Desktop CPU Supplies
- Single-Supply Synchronous Buck Converters
- Mobile Computing CPU Core Power Converters
- Standard-to-Synchronous Converter Adaptations
- High Frequency Switching Converters

DESCRIPTION

The Si9912 is a dual MOSFET high-speed driver with break-before-make. It is designed to operate in high frequency dc-dc switchmode power supplies. The high-side driver is bootstrapped to handle the high voltage slew rate associated with "floating" high-side gate drivers. Each driver is capable of switching a 3000-pF load with 60-ns propogation delay and 25-ns transition time. The Si9912 comes with an internal break-before-make feature to prevent shoot-through current in the external MOSFETs. A shutdown pin is used to enable the driver. When disabled, the quiescent current of the driver is less than 5 μA.

The Si9912 is available in an 8-pin SOIC package for operation over the industrial operation range (–40°C to 85°C).

FUNCTIONAL BLOCK DIAGRAM AND TRUTH TABLE
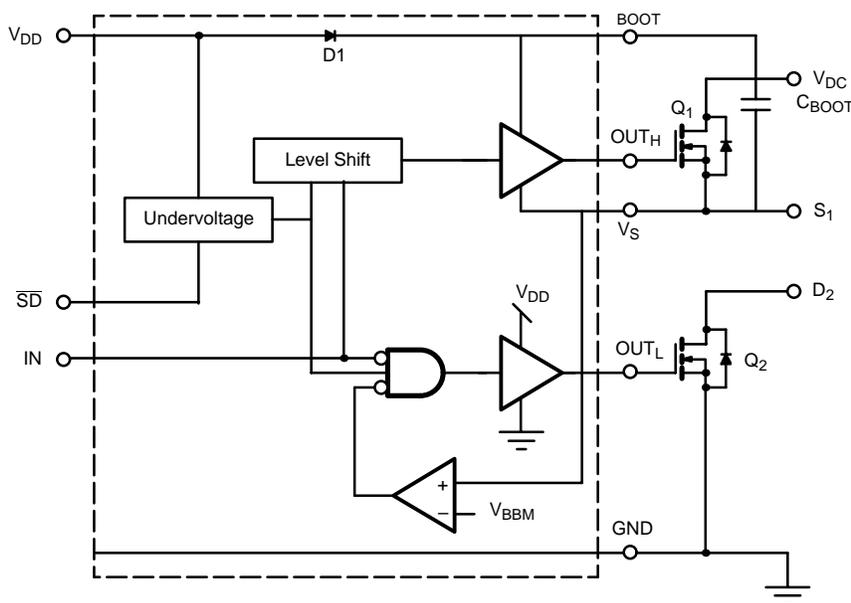
TRUTH TABLE

V_S	$\overline{SD}$	IN	V_{OUTL}	V_{OUTH}
L	L	L	L	L
L	L	H	L	L
L	H	L	H	L
L	H	H	L	H
H	L	L	L	L
H	L	H	L	L
H	H	L	L	L
H	H	H	L	H

ABSOLUTE MAXIMUM RATINGS (T$_A$ = 25°C UNLESS OTHERWISE NOTED)

Parameter	Symbol	Limit	Unit
Low Side Driver Supply Voltage	V$_{DD}$	7.0	V
Input Voltage on IN	V$_{IN}$	−0.3 to V$_{DD}$ +0.3	
Shutdown Pin Voltage	V$_{\overline{SD}}$	−0.3 to V$_{DD}$ +0.3	
Bootstrap Voltage	V$_{BOOT}$	35.0	
High Side Driver (Bootstrap) Supply Voltage	V$_{BOOT}$ − V$_S$	7.0	
Operating Junction Temperature Range	T$_J$	−40 to 125	°C
Storage Temperature Range	T$_{stg}$	−40 to 150	
Power Dissipation (Note a and b)	P$_D$	830	mW
Thermal Impedance	θ$_{JA}$	125	°C/W
Lead Temperature (soldering 10 Sec)		300	°C

Notes
a. Device mounted with all leads soldered to P.C. Board
b. Derate 8.3 W/°C above 25°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS

| Parameter	Symbol	Limit	Unit
Bootstrap Voltage (High-Side Drain Voltage)	V$_{BOOT}$	4.5 to 30	V
Logic Supply	V$_{DD}$	4.5 to 5.5	
Bootstrap Capacitor	C$_{BOOT}$	100 n to 1 μ	F
Ambient Temperature	T$_A$	−40 to 85	°C

SPECIFICATIONS

Parameter	Symbol	Test Conditions Unless Specified V$_{DD}$ = 4.5 to 5.5 V, V$_{BOOT}$ = 4.5 to 30 V, T$_A$ = −40 to 85°C	Limits Min[a]	Typ[b]	Max[a]	Unit
Power Supplies						
V$_{DD}$ Supply	V$_{DD}$		4.5			μA
I$_{DD}$ Supply	I$_{DD1(en)}$	$\overline{SD}$ = H, IN = H, V$_S$ = 0 V			1000	
I$_{DD}$ Supply	I$_{DD2(en)}$	$\overline{SD}$ = H, IN = L, V$_S$ = 0 V			500	
I$_{DD}$ Supply	I$_{DD3(dis)}$	$\overline{SD}$ = L, IN = X, V$_S$ = 0 V			5	
I$_{DD}$ Supply	I$_{DD4(en)}$	$\overline{SD}$ = H, IN = X, V$_S$ = 25 V, V$_{BOOT}$ = 30 V			200	
I$_{DD}$ Supply	I$_{DD5(dis)}$	$\overline{SD}$ = L, IN = X, V$_S$ = 25 V, V$_{BOOT}$ = 30 V			5	
I$_{DD}$ Supply	I$_{DD(en)}$	F$_{IN}$ = 300 kHz, $\overline{SD}$ = High, Driving 2 X Si4412DY		9		mA
	I$_{DD(dis)}$	F$_{IN}$ = 300 kHz, $\overline{SD}$ = Low, Driving 2 X Si4412DY		3		μA
Boot Strap Current	I$_{BOOT}$	V$_{BOOT}$ = 30 V, V$_S$ = 25 V, V$_{OUTH}$ = High	0.9		3	mA
Reference Voltage						
Break-Before-Make Reference Voltage	V$_{BBM}$		1.1		3	V
Logic Inputs ($\overline{SD}$, IN)						
Input High	V$_{IH}$		0.7 × V$_{DD}$		V$_{DD}$ + 0.3	V
Input Low	V$_{IL}$		−0.3		0.3 × V$_{DD}$	
Undervoltage Lockout						
V$_{DD}$ Undervoltage	V$_{UVL}$	V$_{DD}$ Rising	3.7		4.3	V
V$_{DD}$ Undervoltage Hysteresis	V$_{HYST}$			0.4		

SPECIFICATIONS

| Parameter	Symbol	Test Conditions Unless Specified $V_{DD} = 4.5$ to 5.5 V $V_{BOOT} = 4.5$ to 30 V, $T_A = -40$ to $85°C$	Limits			Unit
			Min[a]	Typ[b]	Max[a]	
Bootstrap Diode						
Diode Forward Voltage	VF_{D1}	Forward Current = 100 mA		0.8	1	V
Output Drive Current						
OUT_H Source Current	$I_{OUT(H+)}$	$V_{BOOT} - V_S = 3.7$ V, $V_{OUTH} - V_S = 2$ V			−0.4	A
OUT_H Sink Current	$I_{OUT(H-)}$	$V_{BOOT} - V_S = 3.7$ V, $V_{OUTH} - V_S = 1$ V	0.4			
OUT_L Source Current	$I_{OUT(L+)}$	$V_{DD} = 4.5$ V, $V_{OUTL} = 2$ V			−0.4	
OUT_L Sink Current	$I_{OUT(L-)}$	$V_{DD} = 4.5$ V, $V_{OUTL} = 1$ V	0.6			
Timing ($C_{LOAD} = 3$ nF)						
OUT_L Off Propagation Delay	$t_{pdl(OUTL)}$	$V_{DD} = 4.5$ V		30		ns
OUT_L On Propagation Delay	$t_{pdh(OUTL)}$			20		
OUT_H Off Propagation Delay	$t_{pdl(OUTH)}$	$V_{BOOT} - V_S = 4.5$ V		30		
OUT_H On Propagation Delay	$t_{pdh(OUTH)}$			20		
OUT_L Turn On Time	$t_{r(OUTL)}$	OUT_L = 10 to 90%		25		
OUT_L Turn Off Time	$t_{f(OUTL)}$	OUT_L = 90 to 10%		25		
OUT_H Turn On Time	$t_{r(OUTH)}$	$OUT_H - V_S$ = 10 to 90%		30		
OUT_H Turn Off Time	$t_{f(OUTH)}$	$OUT_H - V_S$ = 90 to 10%		20		

Notes
a. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
b. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.

TIMING WAVEFORMS

PIN CONFIGURATION

SO-8

OUT$_H$	1	8	V$_S$
GND	2	7	BOOT
IN	3	6	V$_{DD}$
$\overline{SD}$	4	5	OUT$_L$

Top View
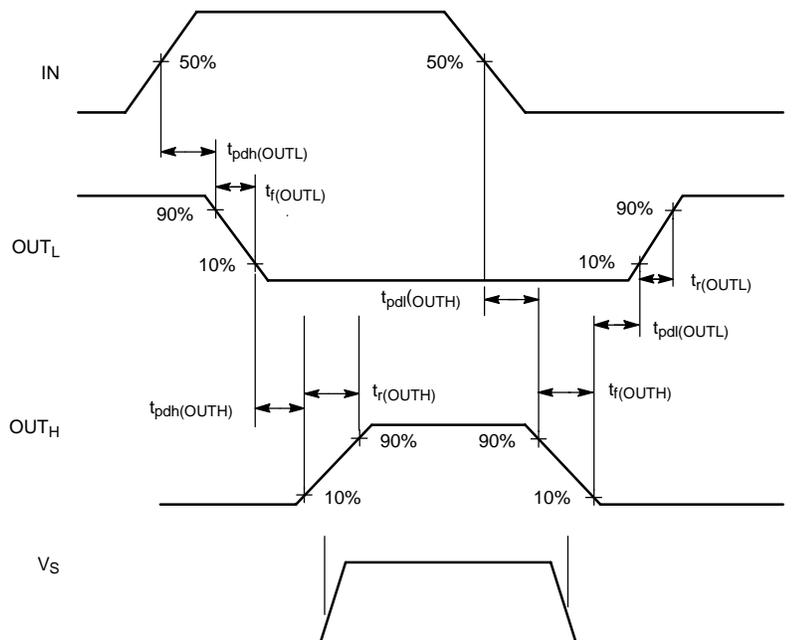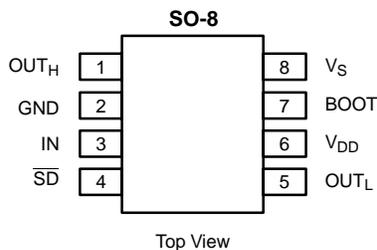
PIN DESCRIPTION

Pin Number	Name	Function
1	OUT$_H$	Output drive for upper MOSFET.
2	GND	Ground supply
3	IN	CMOS level input signal. Controls both output drives.
4	$\overline{SD}$	Shutdown pin
5	OUT$_L$	Output drive for lower MOSFET.
6	V$_{DD}$	Input power supply
7	BOOT	Floating bootstrap supply for the upper MOSFET
8	V$_S$	Floating GND for the upper MOSFET. V$_S$ is connected to the buck switching node and the source side of the upper MOSFET.

ORDERING INFORMATION

Part Number	Temperature Range	Package
Si9912DY	−40 to 85°C	Bulk
Si9912DY-T1		Tape and Reel

Eval Kit	Temperature Range	Board Type
Si9912DB	−40 to 85°C	Surface Mount

TYPICAL WAVEFORMS

Driver On Switch Delay

Si9912 tr, tf, tpd
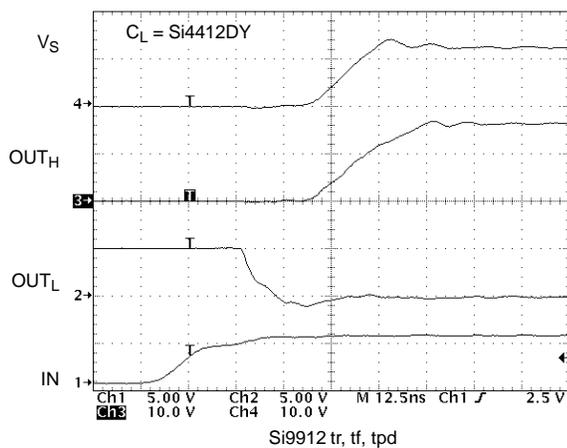
Driver Off Switch Delay

Si9912 tr, tf, tpd
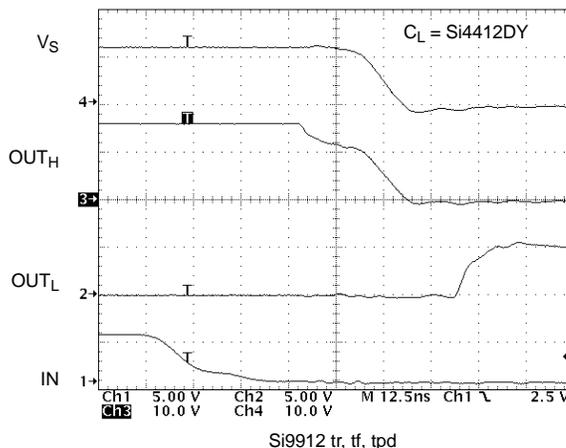
TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

**I_{DD} Supply Current vs. Frequency**
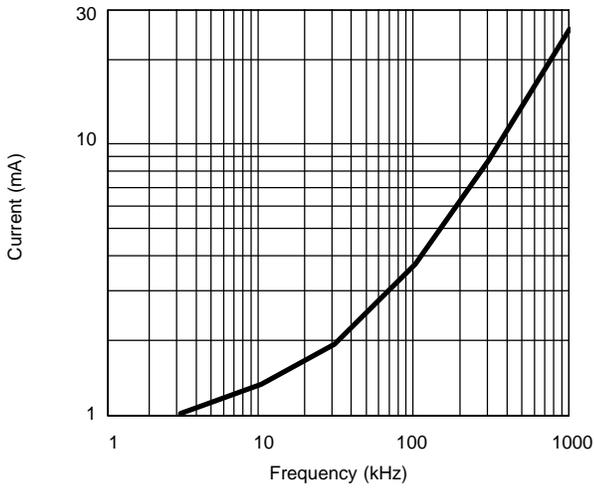
Rise and Fall Time vs. C_{LOAD}
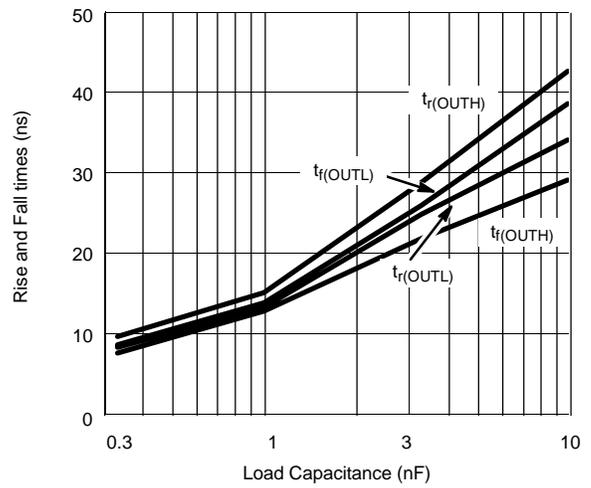
$V_{OUT(H+)}$ vs. Supply
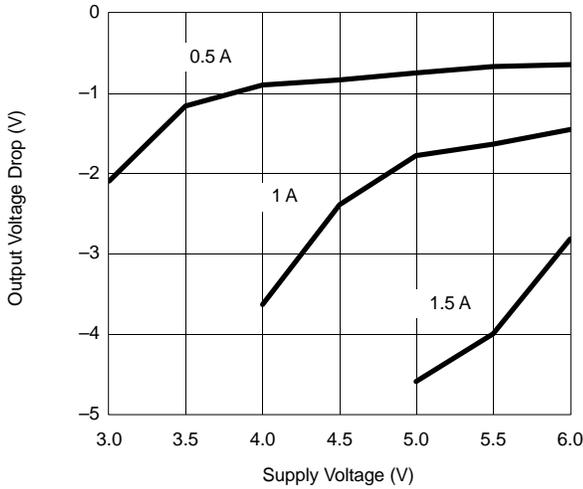
$V_{OUT(H-)}$ vs. Supply
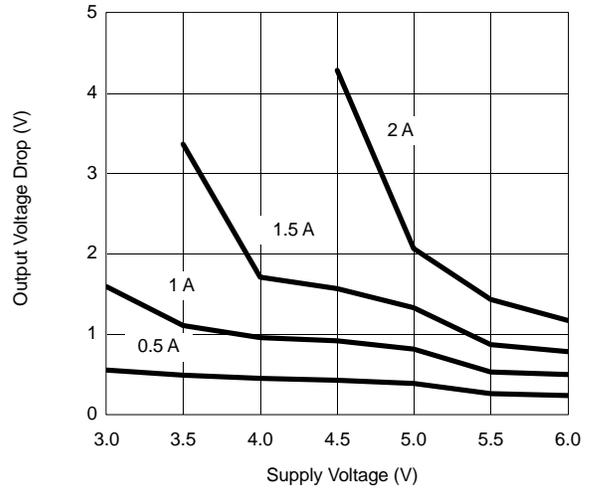

$V_{OUT(L+)}$ vs. Supply
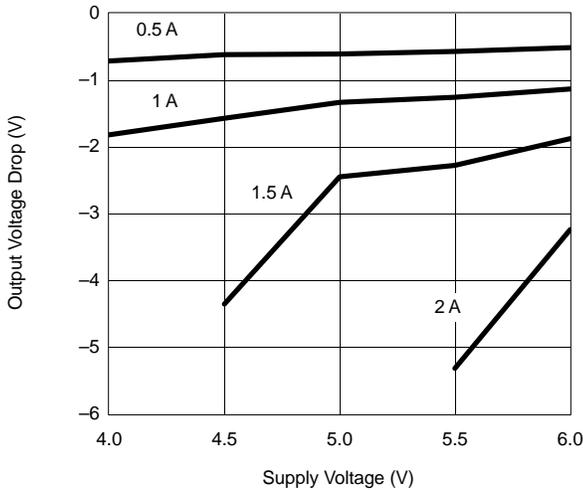
$V_{OUT(L-)}$ vs. Supply

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

V$_{OUT(H+)}$ vs. Temperature

V$_{OUT(H-)}$ vs. Temperature

V$_{OUT(L+)}$ vs. Temperature

V$_{OUT(L-)}$ vs. Temperature
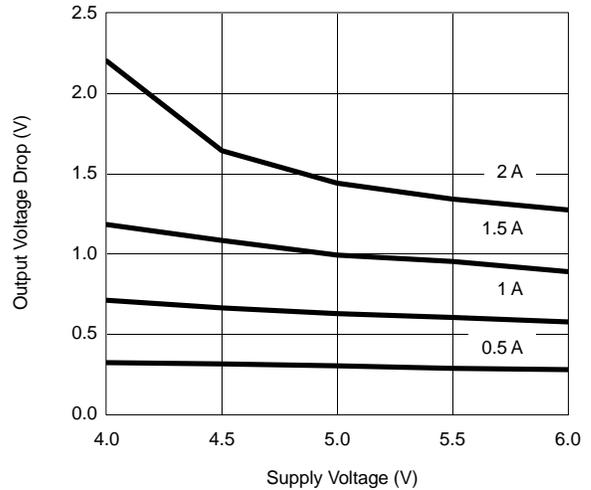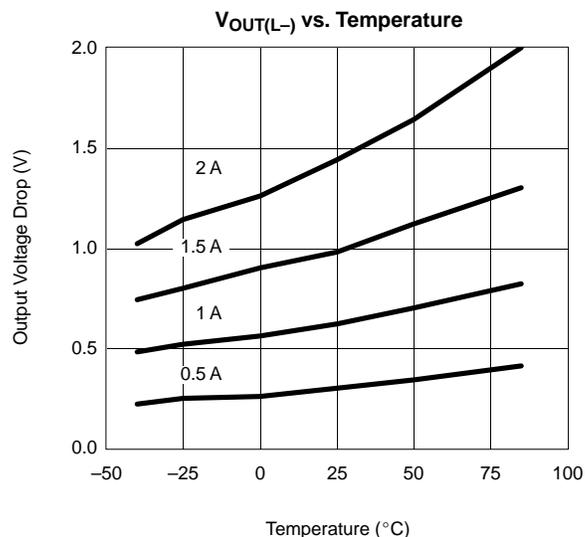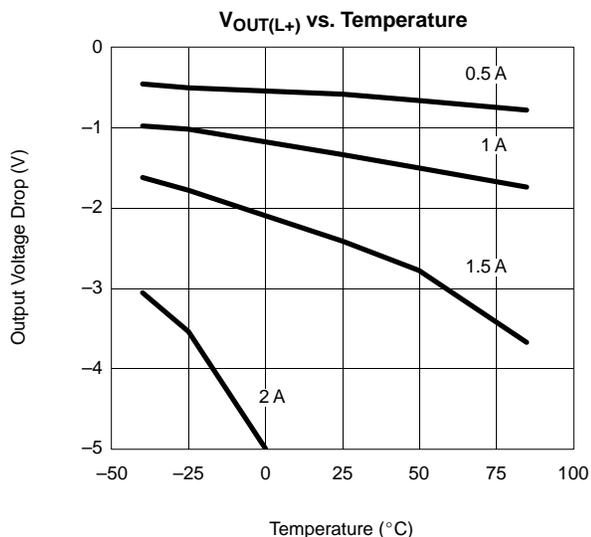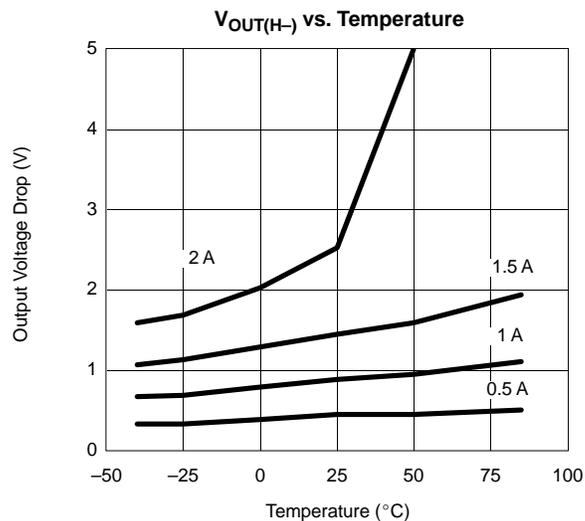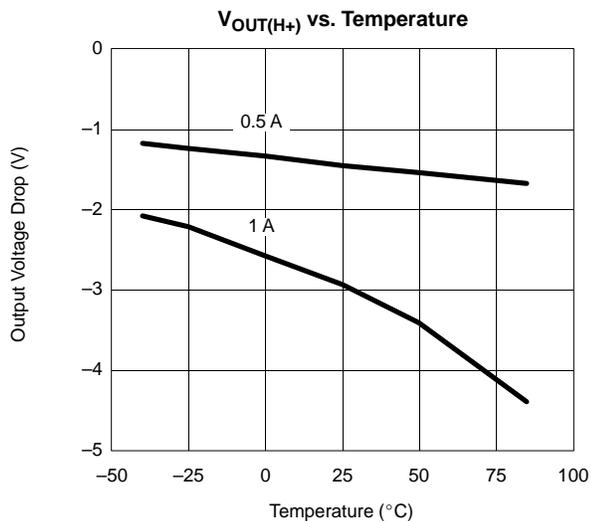
THEORY OF OPERATION

Break-Before-Make Function

The Si9912 has an internal break-before-make function to ensure that both high-side and low-side MOSFETs are not turned on at the same time. The high-side drive (OUT$_H$) will not turn on until the low-side gate drive voltage (measured at the OUT$_L$ pin) is less than V$_{BBM}$, thus ensuring that the low-side MOSFET is turned off. The low-side drive (OUT$_L$) will not turn on until the voltage at the MOSFET half-bridge output (measured at the V$_S$ pin) is less than V$_{BBM}$, thus ensuring that the high-side MOSFET is turned off.

Under Voltage Lockout Function

The Si9912 has an internal under-voltage lockout feature to prevent driving the MOSFET gates when the supply voltage (at V$_{DD}$) is less than the under-voltage lockout specification (V$_{UVL}$). This prevents the output MOSFETs from being turned on without sufficient gate voltage to ensure they are fully on. There is hysteresis included in this feature to prevent lockout from cycling on and off.